

<b>Notice of References Cited</b>	Application/Control No. 10/540,174	Applicant(s)/Patent Under Reexamination CATTON ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0148427 A1	10-2002	Jones et al.	123/184.61
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	J	US-			
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	L	US-			
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**NON-PATENT DOCUMENTS**

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